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Publication Date

2022-02-01

DOI

10.1016/j.ijheatmasstransfer.2021.122189

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1 Unified Descriptor for Enhanced Critical Heat Flux
2 during Pool Boiling of Hemi-wicking Surfaces

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6

7 KEYWORDS

8 Critical heat flux, Roughness, Wettability, Capillary wicking, Phase change heat transfer

9

10 ABSTRACT

11 Boiling heat transfer is dictated by interfacial phenomena at the three-phase contact line where
12 vapor bubbles form on the surface. Structured surfaces have shown significant enhancement in
13 critical heat flux (CHF) during pool boiling by tailoring interfacial phenomena. This CHF
14 enhancement has been primarily explained by two structural effects: roughness, which extends the
15 contact line length at the bubble base, and wickability, the ability to imbibe liquid through surface
16 structures by capillary pumping. In this work, we show that CHF enhancement on structured
17 surfaces cannot be described by roughness or wickability alone. This result was confirmed using
18 systematically designed micropillar surfaces with controlled roughness and wickability. Further,

1 we performed a scaling analysis and derived a unified descriptor, which represents the combined
2 effects of thin film density and volumetric wicking rate. This unified descriptor shows a reasonable
3 correlation with CHF values with our experiments and literature data. This work provides
4 important insights in understanding the role of surface structures on CHF enhancement, thereby
5 providing guidelines for the systematic design of surface structures for enhanced pool boiling heat
6 transfer.

7

8 1. INTRODUCTION

9 Boiling is a vital process used to transfer heat effectively via harnessing the large latent
10 heat of vaporization for a variety of energy applications. A major boiling parameter of interest is
11 the critical heat flux (CHF, q''_{CHF}), the amount of heat that can be transferred over a specific area
12 before exceeding the operational limit. Above CHF, a transition from the nucleate boiling to film
13 boiling known as the boiling crisis occurs. During this process, coalesced vapor bubbles form a
14 vapor film that becomes a dominant thermal resistance and can lead to thermal runaway resulting
15 in catastrophic failure of systems.

16 Enhancing CHF, therefore, has been widely investigated to extend the operational limit
17 and allow for larger safety margins for boiling systems [1, 2], by engineering boiling surface
18 structures, e.g., micropillar, microchannel, microridge, and nanowire [3-7]. Meanwhile,
19 fundamental understanding of the mechanism for enhanced CHF on such structured surfaces has
20 been a subject of debate for over half a century. A force balance model on a static bubble, for
21 example, attributes the CHF enhancement on structured surfaces to the augmented three-phase
22 contact line length along the structures [3]. This static force balance model proposes surface

1 roughness, r , the ratio of actual surface area to the projected area, as a key structural property
2 determining CHF that shows a reasonable correlation with experimentally measured CHF values
3 [3, 8]. Another major group of CHF models attributes the CHF enhancement to the improved
4 liquid rewetting by capillary pumping through surface structures, i.e., wickability. Structured
5 surfaces that exhibit capillary-induced wicking are referred to as hemi-wicking surfaces. This
6 capillary-induced flow occurs when the critical contact angle of a structured surface, $\theta_c =$
7 $\cos^{-1}[(1 - \varphi)/(r - \varphi)]$, becomes larger than the intrinsic contact angle, θ , where φ is the solid
8 fraction at the solid-liquid interface. Most previous wickability-based models express the CHF of
9 a hemi-wicking surface as the sum of the flat surface CHF, q''_{flat} , and an additional evaporation
10 heat flux from a wicked liquid, q''_w , i.e., $q''_{\text{CHF}} = q''_{\text{flat}} + q''_w$. In this case, q''_w has been
11 characterized by a separate experimental measurement such as capillary rise height [9],
12 spreading or absorption of liquid droplets [10, 11], and volumetric wicking flux of a pendant
13 droplet [12, 13]. In addition to CHF models based on the experimentally characterized q''_w , a
14 semi-analytical CHF model has been proposed by characterizing the surface wickability using
15 Darcy's law [4]. The model derived a property related to the surface wickability: $P_{\text{cap}}K_B$ that
16 determines CHF values of hemi-wicking surfaces. Here P_{cap} is the capillary pressure and K_B is
17 the effective permeability (a permeability that incorporates shear stress from the bottom surface).

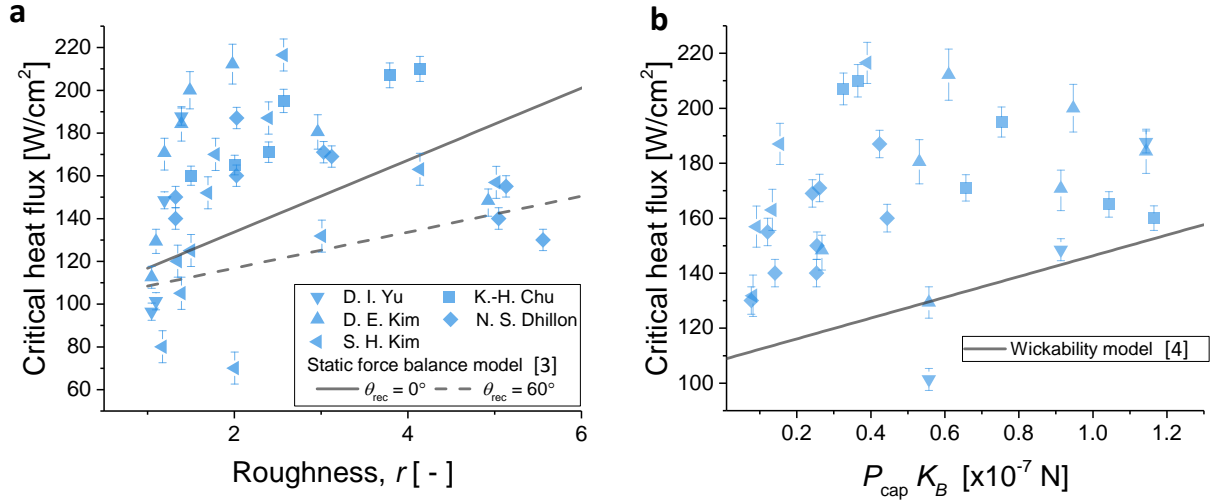
18 While CHF models based on roughness and wickability show good agreement with the
19 corresponding experimental data, neither r (Figure 1a) nor $P_{\text{cap}}K_B$ (Figure 1b) can provide a
20 general correlation for CHF, if we combine the existing literature data on Si and SiO₂ hemi-
21 wicking surfaces. Inconsistent surface preparation or different boiling characterization methods
22 across the literature may partly explain the discrepancy among different data sets [14, 15];
23 nonetheless, the unclear correlations of CHF values with roughness or wickability suggest that a

1 single property, i.e., roughness or wickability, is insufficient to describe CHF values of hemi-
2 wicking surfaces. Recently, wickability-based models have included the structural effects on
3 evaporation [16, 17]. In particular, an analytical model has proposed that the competition
4 between evaporation and wicking fluxes associated with a varying dry area determines the CHF
5 [17]. This model provides an important insight into the structural effects on evaporation;
6 however, the model is highly sensitive to empirical parameters that are difficult to measure, e.g.,
7 bubble base diameter, accommodation coefficient, and thin-film thickness. Apart from roughness
8 and wickability, a few studies have suggested that the boiling crisis is a critical phenomenon
9 associated with stochastic bubble interactions [18-23]. Specifically, a machine learning-aided
10 analysis has revealed that fundamental boiling parameters, e.g., nucleation site density, bubble
11 departure frequency, growth time, and bubble base radius, need to be taken into account for the
12 stochastic bubble interactions and the resulting CHF [22]. The structural effects on those
13 fundamental boiling parameters, however, need further investigation.

14

15

16



1
2 **Figure 1.** CHF data of hemi-wicking micropillar surfaces across the literature plotted with
3 representative CHF models based on the (a) roughness r and (b) the product of capillary pressure
4 and effective permeability $P_{cap}K_B$. The plots show no clear correlation between CHF values and
5 r or $P_{cap}K_B$. Table S1 in the Supporting Information summarizes all of the data points in the
6 plots.

7
8 In this work, we revisit the validity of previous roughness- and wickability-based CHF
9 models using micropillar surfaces with systematically controlled roughness and wickability. By
10 testing micropillar surfaces with a fixed roughness while varying wickability, and vice versa, we
11 decoupled effects of each parameter on CHF values. Further, by leveraging our experimental
12 results and previous visualization studies of boiling bubbles [18, 24, 25], we derived a unified
13 descriptor using a scaling analysis. CHF values of our experiments and the literature data
14 confirmed the scaling analysis. This work provides physical insights into the structural effects on

1 CHF, which can offer more general guidelines for the design of surface structures for high flux
2 boiling applications.

3

4 2. DESIGN AND FABRICATION OF MICROPILLARS

5 Roughness is quantified as the ratio of actual surface area (A_{actual}) to projected area
6 (A_{prj}) by $r = \frac{A_{\text{actual}}}{A_{\text{prj}}} = 1 + \frac{\pi dh}{p^2}$ for square micropillar arrays, where d , h , and p are the diameter,
7 height, and pitch (pillar center-to-center distance) of micropillars (Figure 2a). Wicking
8 performance is characterized as a product of the capillary pressure P_{cap} and the effective
9 permeability K_{B} according to the previous semi-analytical model for CHF [4]. The capillary
10 pressure is evaluated based on the liquid meniscus shape around micropillars that minimizes free
11 energy: $P_{\text{cap}} = -\Delta E / \Delta V$, where ΔE and ΔV are the change in the free energy and volume due to
12 the liquid filling into a unit cell of the micropillar array, respectively (detailed expressions appear
13 in Section I of the Supporting Information) [17, 26]. We adopted the permeability correlation
14 proposed by Yazdchi et al. [27], which combines the correlations developed by Gebart et al. [28]
15 and Drummond and Tahir [29]. The permeability correlation proposed by Yazdchi et al., shows
16 good agreement with experiments for the entire range of porosity ε [30], where the porosity is
17 calculated as $\varepsilon = 1 - \frac{\pi d^2}{4p^2}$ for square micropillar arrays. Since this permeability K is developed
18 for pillar arrays with unbounded top and bottom conditions, an additional term is required for our
19 micropillar surfaces to account for the shear stress from the bottom surface. The effective
20 permeability K_{B} accounting for viscous resistances from both the bottom surface and pillar

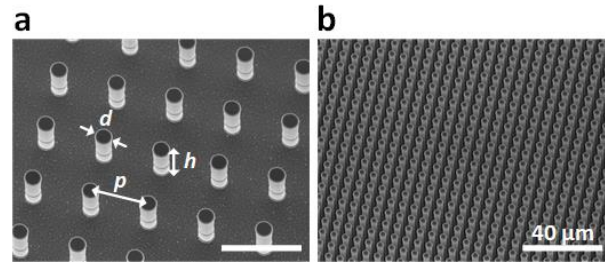
1 sidewalls, can be derived by solving the Brinkman equation with a no-slip condition at the
2 bottom surface [17, 31].

$$K_B = K \left[1 - \frac{\tanh(h\sqrt{\varepsilon/K})}{h\sqrt{\varepsilon/K}} \right]. \quad (1)$$

3 Detailed analysis on permeability is available in Section II of the Supporting Information [17, 27,
4 30]. Previous representative CHF models describe the CHF value as a function of either
5 roughness or surface wickability. In fact, roughness and wickability depend on each other to
6 some extent. For example, with the increase in the structural packing density, roughness
7 generally increases, while liquid wicking speed increases and then decreases, leading to an
8 optimal value due to the competition between capillary pressure and viscous resistance [26].
9 Therefore, decoupling the effect of roughness or wickability on CHF has not been
10 straightforward. To investigate the decoupled effects of roughness and wickability on CHF
11 values during pool boiling, we systematically designed a set of micropillar surfaces with varying
12 r for a specific $P_{\text{cap}}K_B$, and vice versa. For example, we designed four different micropillar
13 arrays with a similar $r \sim 2.0$, while changing $P_{\text{cap}}K_B$ from 0.81×10^{-7} to 1.22×10^{-7} N
14 (Sample #1, 2, 3, and 7). Likewise, we designed three different micropillar arrays with a similar
15 $P_{\text{cap}}K_B$ value of $\sim 0.81 \times 10^{-7}$ N, while changing r from 1.5 to 3.0 (Sample #1, 4, and 5). In
16 addition, a micropillar arrays with extremely high r but low $P_{\text{cap}}K_B$ was included to investigate a
17 wider range of structural effects. Table 1 summarizes the dimensions and properties of all
18 samples. We fabricated micropillar arrays through photolithography and deep reactive-ion
19 etching (DRIE) processes on silicon wafers. At the end of the fabrication process, we etched
20 away a C_4F_8 DRIE passivation layer by O_2 plasma and deposited a 60 nm SiO_2 layer over the
21 entire surface by atomic layer deposition to ensure uniform hydrophilicity over the surface.

1 Details of the fabrication process are available in Section III of the Supporting Information.
 2 Figure 2 shows scanning electron microscopy (SEM) images of the fabricated micropillar arrays
 3 with the highest $P_{\text{cap}}K_B$ (Figure 2a, sample #3) and the highest r (Figure 2b, sample #6) among
 4 all samples.

5



6

7 **Figure 2.** SEM images of micropillar arrays with dimensions of (a) $d = 12 \mu\text{m}$, $p = 30 \mu\text{m}$, $h =$
 8 $30 \mu\text{m}$, and (b) $d = 3 \mu\text{m}$, $p = 6 \mu\text{m}$, $h = 30 \mu\text{m}$. The micropillar arrays in (a) and (b) have the
 9 highest $P_{\text{cap}}K_B$ and r , respectively, among seven different micropillar surfaces fabricated.

10

11 **Table 1.** Dimensions and properties of micropillar arrays. The roughness (r) and porosity (ε) are
 12 calculated as $r = 1 + \pi dh/p^2$ and $\varepsilon = 1 - \pi d^2/(4p^2)$, respectively. Two wicking properties
 13 are characterized, where $P_{\text{cap}}K_B$ and $P_{\text{cap}}K_B h$ are related to the speed of the wicking liquid front
 14 and volumetric wicking flow rate, respectively [17, 32].

Sample #	d [μm]	p [μm]	h [μm]	r [-]	ε [-]	$P_{\text{cap}}K_B$ [$\times 10^{-7}$ N]	$P_{\text{cap}}K_B h$ [$\times 10^{-12}$ N·m]
1	4	20	30	1.9	0.968	0.81	4.56
2	7	25	30	2.0	0.938	1.05	6.06
3	12	30	30	2.2	0.874	1.22	7.24
4	3	23	30	1.5	0.987	0.75	3.41
5	11	23	30	3.0	0.820	0.86	6.26
6	3	6	30	8.8	0.804	0.21	4.56

7	8	30	30	1.8	0.944	1.20	6.25
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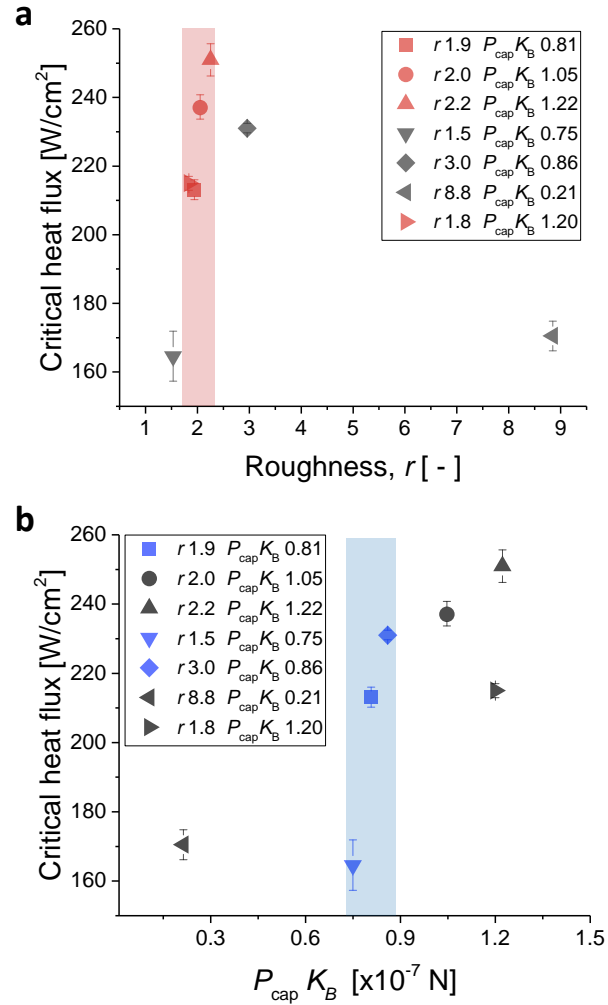
2 3. POOL BOILING MEASUREMENTS

3 We measured CHF values during pool boiling with high-purity deionized water by
4 applying heat flux through a 100 nm-thick serpentine Pt heater ($10 \times 15 \text{ mm}^2$) deposited on the
5 backside of each micropillar sample ($12 \times 18.5 \text{ mm}^2$). The Pt serpentine heater also served as a
6 resistance temperature detector for the temperature characterization. We cleaned all samples with
7 solvents (in the order of acetone, methanol, and isopropyl alcohol) followed by argon plasma
8 before boiling to avoid unexpected alteration of CHF values by organic contaminants [14]. The
9 pre-heated water was then introduced into the boiling chamber, which was degassed further by
10 an immersion heater for 30 minutes before experimental measurements. We measured a voltage
11 drop (V) and electric current (I) across the heater by gradually increasing the applied voltage up
12 to the CHF point, where the heater resistance, i.e., sample temperature, drastically increased. The
13 input heat flux was calculated as $q''_{\text{in}} = (I \times V)/A_{\text{h}}$, where A_{h} is the heating area of 10×15
14 mm^2 . The bottom surface temperature was characterized by the resistance of heater, i.e., $R =$
15 V/I , according to a pre-calibrated linear relationship between the resistance and temperature.
16 Due to the slight size mismatch between the sample and heater, we numerically calibrated the
17 experimentally measured data (COMSOL Multiphysics 5.3a) to account for the lateral heat
18 spread across the sample. The details of the experimental setup and boiling characterization
19 methods appear in Section IV of the Supporting Information.

20 For each micropillar geometry, we measured CHF values with two different samples.
21 Figure 3 shows the average CHF values as a function of r and $P_{\text{cap}}K_{\text{B}}$. Our boiling results show

1 no clear correlation between CHF values and r and $P_{\text{cap}}K_B$, which confirms that the discrepancy
2 between the literature data and previous CHF models (Figure 1) cannot be attributed to
3 inconsistent surface conditions or boiling characterization methods across the literature only.
4 Rather, the results directly show that CHF values on hemi-wicking surfaces cannot be described
5 by either r or $P_{\text{cap}}K_B$ alone. Interestingly, however, CHF values generally increase with either r
6 or $P_{\text{cap}}K_B$ when the other parameter is fixed, indicating that r and $P_{\text{cap}}K_B$ may have separate
7 effects on CHF values. In Figure 3a, for example, the micropillar arrays with a similar r value
8 ($r \approx 2$ for sample #1, 2, 3, and 7, colored in red) shows an increase in CHF values as $P_{\text{cap}}K_B$
9 increases except for one case (sample #7). Likewise, we found higher CHF values for micropillar
10 arrays with higher r when $P_{\text{cap}}K_B$ remained similar ($P_{\text{cap}}K_B \approx 0.8 \times 10^{-7}$ N for sample #1, 4,
11 and 5, colored in blue) as shown in Figure 3b.

12



1

2 **Figure 3.** CHF values of micropillar arrays as a function of (a) r and (b) $P_{\text{cap}} K_B$. Data points
 3 show the average CHF values measured from two different samples for each pillar array. CHF
 4 values showed no clear correlation with both parameters. (a) For micropillar arrays with a similar
 5 r (colored in red), however, higher $P_{\text{cap}} K_B$ generally resulted in higher CHF values. (b) Likewise,
 6 higher r resulted in higher CHF values for micropillar arrays with a similar $P_{\text{cap}} K_B$ (colored in
 7 blue). The experimental measurement uncertainty was smaller than the marker size. The error
 8 bars were deviations of measurements on each sample from the average.

9

1 4. SCALING APPROACH

2 Although it is possible to understand the structural effects using a varying-dry-area model
3 [17], this approach is highly sensitive to several empirical parameters such as bubble base
4 diameter, accommodation coefficient, and thin-film thickness, which makes it challenging to
5 directly assess the structural effects shown in our experiments. The detailed analysis on the
6 varying-dry-area model is provided in Section V of the Supporting Information [17].
7 Alternatively, we applied a scaling approach to interpret our experimental results with minimal
8 uncertainties from the empirical parameters. Considering that the contribution of convective heat
9 transfer by single-phase liquid to the total boiling heat flux is insignificant near CHF [33, 34],
10 CHF can be expressed as $q''_{CHF} \approx \rho_l h_{fg} N'' f V_{l,CHF}$, where ρ_l , h_{fg} , N'' , f , and $V_{l,CHF}$ are the
11 density of liquid, latent heat of vaporization, bubble nucleation site density, bubble departure
12 frequency, and volume of evaporating liquid per bubble at CHF, respectively. Since structural
13 dimensions of micropillars do not affect the nucleation site density significantly near CHF [16],
14 we consider the nucleation site density roughly constant and scale the heat flux near CHF as
15 $q''_{CHF} \sim f V_{l,CHF}$. The bubble departure frequency f describes how quickly bubbles nucleate and
16 depart from a boiling surface. Specifically, if we assume bubbles depart at a characteristic
17 volume V_d , at which buoyancy overcomes the surface tension force and drag force, V_d can be
18 expressed as $V_d = q''_{ev} \frac{\tau_d A_b}{\rho_v h_{fg}}$, where q''_{ev} , τ_d , A_b , and ρ_v are evaporation heat flux under a
19 bubble, bubble departure period, bubble base area, and the density of vapor, respectively [35].
20 Assuming the thermophysical properties of water are constant, the departure frequency scales as
21 $f = \frac{1}{\tau_d} \sim q''_{ev}$, i.e., surface structures with stronger evaporation can have higher bubble departure
22 frequency. Given the high thermal conductivity of silicon, we can expect that dense micropillar

1 arrays may provide effective heat transfer for evaporation. In addition, when bubbles nucleate on
2 micropillar surfaces (Figure 4a), the three-phase contact line pins at the top of micropillars and
3 forms thin liquid films around the micropillars (Figure 4b – d). This thin film provides efficient
4 heat transfer paths through their thin thickness ($\leq 1 \mu\text{m}$). Since the density of thin films (ξ)
5 (shaded red regions in Figure 4b (top view) and 4c (cross-section view)) scales with the density
6 of micropillars, i.e., $\xi \approx \frac{\pi d \delta_{\text{tf}}}{p^2} \sim \frac{d \delta_{\text{tf}}}{p^2}$, where δ_{tf} is the thin-film thickness threshold, the
7 evaporation heat flux is expected to scale with the density of the thin film. Here the thin film
8 density ξ is similar to roughness r , where both capture the structural packing density, but ξ is not
9 dependent on the micropillar height. To confirm the scaling between the thin film density and
10 evaporation heat flux, we modeled the thin-film evaporation in the unit cell of micropillar array
11 (Figure 4c). The heat transfers from the boiling surface at the wall temperature (T_w) to the vapor
12 bubble at the saturation temperature (T_{sat}) passing a silicon micropillar and bulk liquid water.
13 Due to the orders of magnitude higher thermal conductivity of silicon ($k_{\text{Si}} \approx 113 \text{ W}/(\text{mK})$ at
14 $100 \text{ }^\circ\text{C}$) than that of water ($k_w \approx 0.68 \text{ W}/(\text{mK})$), we simplified the heat transfer path to be a
15 one-dimensional resistance network including a micropillar and the surrounding thin liquid film.

16 The conduction resistance through a micropillar is $R_{\text{Si}} = \frac{4h}{\pi d^2 k_{\text{Si}}}$. The thermal resistance of the
17 thin liquid film can be calculated given the thin-film thickness profile, $\delta(z)$, along the distance

18 from the micropillar top z as $R_{\text{tf}} = \left[2k_w \pi \int_{z_{\text{ads}}}^{z_{\text{tf}}} \frac{(\delta + \frac{d}{2}) \sqrt{1 + (\frac{d\delta}{dz})^2}}{\delta} dz \right]^{-1}$ [36], where z_{tf} and z_{ads} are z

19 values corresponding to thin-film thickness threshold (δ_{tf}) and non-evaporating adsorption layer
20 thickness (δ_{ads}), respectively (Figure 4d). Here the thin-film thickness threshold and adsorption
21 layer thickness are defined as $1 \mu\text{m}$ and 0.3 nm , respectively [37, 38]. The interfacial resistance

1 is estimated using the Schrage equation as $R_{\text{int}} = \frac{1}{A_{\text{int}}} \left(\frac{2-\chi}{2\chi} \right) \left(\frac{T_v v_{\text{lv}}}{h_{\text{fg}}^2} \right) \left(\frac{2\pi \bar{R} T_v}{\bar{M}} \right)^{1/2} \left(1 - \frac{P_v v_{\text{lv}}}{2h_{\text{fg}}} \right)^{-1}$,

2 where A_{int} and χ are the thin-film interfacial area and accommodation coefficient, respectively.

3 The accommodation coefficient is set to 0.03 in our calculations [39]. T_v , P_v , and v_{lv} are the

4 vapor temperature, vapor pressure, and specific volume difference between the vapor and liquid

5 phases, respectively. \bar{R} is the universal gas constant (8.314 J/(molK)) and \bar{M} is the molar mass

6 of water (0.01801 kg/mol). The effective thermal resistance (R_{tot}) in one unit cell is then

7 evaluated as $R_{\text{tot}} = R_{\text{Si}} + R_{\text{tf}} + R_{\text{int}}$, where the evaporation heat flux through one unit cell is

8 $q''_{\text{ev}} = \frac{T_w - T_{\text{sat}}}{R_{\text{tot}} \rho^2}$. The additional details of the thin-film evaporation model and scaling are

9 provided in Section V of the Supporting Information [36]. We evaluated q''_{ev} and ζ for

10 micropillar arrays with a fixed height of 30 μm , while changing the pitch for pillar diameters of

11 5, 7, and 10 μm . The resulting plot of q''_{ev} normalized by the CHF value on a flat surface

12 ($q''_{\text{flat}} = 99.45 \text{ W/cm}^2$) as a function of ζ (Figure 4e) monotonically increase while the

13 derivative of the function decreases. Based on the shape of the curves, we scale the evaporation

14 heat flux as $q''_{\text{ev}} \sim \zeta^n$ with $0 < n < 1$. Note that we do not determine the value of the exponent n

15 based on the modeling results, because the model depends on empirical parameters such as

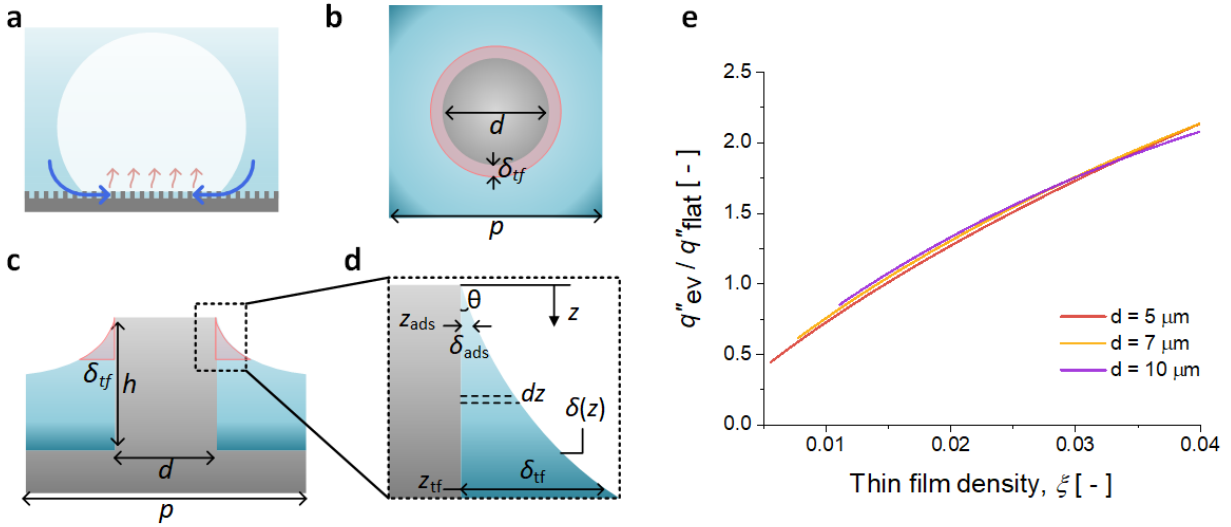
16 contact angle, accommodation coefficient, and thin-film thickness. Instead, we leave the

17 exponent to be determined by the experimental results. Consequently, the departure frequency

18 can be scaled to yield

$$f \sim q''_{\text{ev}} \sim \zeta^n, \text{ where } 0 < n < 1 \quad (2)$$

19



1
2 **Figure 4.** Structural effects on evaporation and rewetting under a boiling bubble on a hemi-
3 wicking surface. (a) A schematic of a bubble nucleating on a hemi-wicking surface. Evaporation
4 (red arrows) occurs from a liquid layer at the bubble base, while capillary-driven wicking (blue
5 arrows) supplies the liquid from the circumference to the center of bubble base. (b) Top-view
6 and (c) cross-sectional view schematics of thin-film evaporation in the unit cell of micropillar
7 array. Shaded red area represents the thin-film region. (d) A magnified view of the thin-film
8 region. (e) Evaporation heat flux normalized by the CHF value on a flat surface (q''_{ev}/q''_{flat}) as a
9 function of thin film density, $\xi \sim \frac{d\delta_{tf}}{p^2}$. The plot shows an increase in evaporation heat flux with
10 thin film density, i.e., $q''_{ev} \sim \xi^n$ with $0 < n < 1$.

11
12 Past synchrotron X-ray visualization of boiling bubbles on hemi-wicking surfaces has revealed
13 that hemi-wicking surfaces maintain liquid layers under the boiling bubbles (as shown in Figure
14 4a) until a heat flux reaches CHF, where the bubble base dries out leading to the boiling crisis
15 [25]. Combining this observation with stochastic bubble interaction models [18, 22], we presume

1 that hemi-wicking surfaces may delay the boiling crisis by maintaining a liquid layer under
 2 bubbles. Once the wicked liquid layer dries out, however, much more dry areas are suddenly
 3 created by the stochastic bubble interactions whereby the boiling crisis occurs. This capability of
 4 maintaining the liquid layer depends on the volumetric wicking flow rate. Therefore, we scale
 5 the volume of evaporating liquid per bubble at CHF ($V_{l,CHF}$) as

$$V_{l,CHF} \sim P_{cap} K_B h, \quad (3)$$

6 where $P_{cap} K_B h$ dictates the volumetric wicking flow rate of a hemi-wicking surface and h is the
 7 thickness of wicked liquid layer, i.e., micropillar height [32]. Note that there can be exceptional
 8 cases such as hemi-wicking surfaces with artificial cavities, e.g., microtube structures, where the
 9 extensive bubble coalescence due to high nucleation site density can limit the liquid supply,
 10 before capillary wicking becomes limiting, and trigger the boiling crisis [40]. Combining
 11 Equation (2) and (3), we obtain a unified descriptor of the CHF,

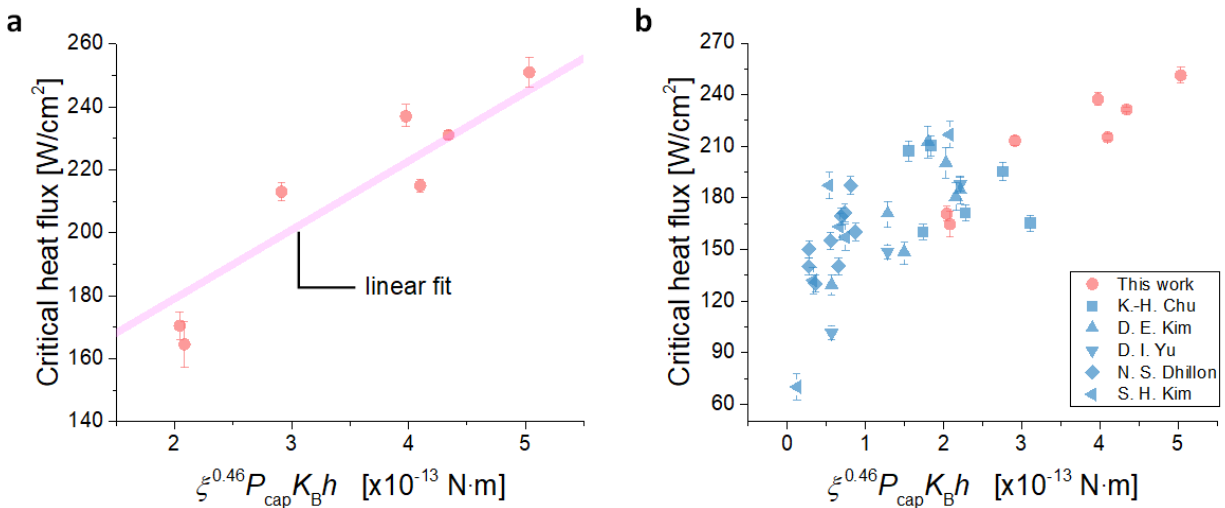
$$q''_{CHF} \sim \xi^n P_{cap} K_B h. \quad (4)$$

12

13 Figure 5a shows our CHF data as a function of the unified descriptor $\xi^n P_{cap} K_B h$. The plot shows
 14 a clear positive correlation between our CHF data and $\xi^n P_{cap} K_B h$, where n of 0.46 showed the
 15 best fit with our dataset (the sensitivity of n is discussed in Section VI of the Supporting
 16 Information). We also included literature data in Figure 5b using the same n , which confirms the
 17 positive linear relationship in a broader range. Here we included the literature data of silicon- and
 18 silicon dioxide-based hemi-wicking surfaces to investigate the sole effect of surface structure
 19 while excluding the effect of material properties. The exponent n , as previously discussed,
 20 depends on experimental and environmental parameters, so it may differ for different literature

1 data sets. This variation of n may lead a weaker correlation for the literature data set in Figure 5b
 2 compared than that of Figure 5a. Nonetheless, the improved correlation between CHF values
 3 with $\xi^n P_{\text{cap}} K_B h$ (Figure 5) when compared to the correlations with r or $P_{\text{cap}} K_B$ alone (Figure 1)
 4 supports our scaling analysis; that is, the combined effect of thin film density and volumetric
 5 wicking rate affect CHF values by enhancing bubble departure frequency and delaying the
 6 growth of dry area, respectively. In fact, the scaling-derived descriptor $\xi^n P_{\text{cap}} K_B h$ has the
 7 combined effects of previous roughness- and wickability-based models, which becomes more
 8 obvious by rearranging the parameters as $(\xi^n h)(P_{\text{cap}} K_B)$. Here $\xi^n h$ is a parameter similar to
 9 roughness r , where their role to achieve enhanced CHF is essentially the extension of the contact
 10 line, and $P_{\text{cap}} K_B$ is the key parameter used in the wickability-based model. This result explains
 11 why the previous models could work for specific data sets. The roughness-based model could
 12 work when the effect of the extended contact line length was dominant, while the wickability-
 13 based model could work when the wickability effect was dominant.

14



15

1 **Figure 5.** Experimentally measured CHF values versus $\xi^{0.46}P_{\text{cap}}K_{\text{B}}h$, where 0.46 is the exponent
2 that fits best for our measurement. (a) CHF scaling results with our data and (b) including the
3 literature data.

4

5 5. CONCLUSIONS

6 In this work, we showed that existing CHF correlations which used roughness or wickability as a
7 single descriptor were limited to specific data sets. To investigate the effects of roughness and
8 wickability on CHF values independently, we designed micropillar arrays with a fixed r while
9 varying $P_{\text{cap}}K_{\text{B}}$, and vice versa. The experimentally measured CHF values on those micropillar
10 arrays showed that, although there were no clear correlations of CHF values with either r or $P_{\text{cap}}K_{\text{B}}$
11 overall, CHF values generally increased with either r or $P_{\text{cap}}K_{\text{B}}$ when the other was fixed. This
12 result directly showed that CHF is not solely a function of either r or $P_{\text{cap}}K_{\text{B}}$; instead, each
13 parameter has separate effects on CHF. To understand the structural effects on CHF values, we
14 performed a scaling analysis to derive a relationship for CHF with a new unified descriptor,
15 $q''_{\text{CHF}} \sim \xi^n P_{\text{cap}}K_{\text{B}}h$. Here ξ^n and $P_{\text{cap}}K_{\text{B}}h$ affect CHF values by promoting bubble departure
16 frequency and delaying the expansion of dry area, respectively. The scaling analysis was
17 confirmed with CHF values from our experiments and literature data. CHF values from our
18 experiments showed a positive linear correlation with $\xi^{0.46}P_{\text{cap}}K_{\text{B}}h$, which also agreed with
19 existing literature data. Our work elucidate the separate roles of thin film density and wickability
20 in enhancing CHF values, which can enable improved designs of boiling surfaces for a variety of
21 high heat flux applications.

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ACKNOWLEDGMENT

We appreciate the helpful discussion with Prof. Daniel J. Preston, Prof. Yangying Zhu, Prof. H. Jeremy Cho, and Dr. Zhengmao Lu on the limitations of previous models and the systematic design of micropillar surfaces. Y. Song acknowledges that the information, data, or work presented herein was funded in part by the Advanced Research Projects Agency-Energy (ARPA-E), U. S. Department of Energy, under Award Number DE-AR0000ABC. L. Zhang acknowledges support from the Singapore-MIT Alliance for Research and Technology (SMART) LEES Program. C. D. Díaz-Marín acknowledges the Air Force Office of Scientific Research under Grant No. FA9550-19-1-0392 with Dr. Ali Sayir as program manager, and a Professor Amar G. Bose Research Grant. S. S. Cruz acknowledges support from National Energy Technology Laboratory (NETL) of the U.S. Department of Energy with Richard Dunst as project manager. This work was performed in part at the Harvard University Center for Nanoscale Systems (CNS); a member of the National Nanotechnology Coordinated Infrastructure Network (NNCI), which is supported by the National Science Foundation under NSF award no. ECCS-2025158.

Highlights

- 1 • Experimentally demonstrated that pool boiling CHF enhancement on hemi-wicking
2 surfaces cannot be explained by roughness or wickability alone.
- 3 • Experimental results of systematically designed micropillar surfaces showed that CHF
4 depends on both roughness and wickability.
- 5 • Performed a scaling analysis to derive a relationship for CHF with a unified descriptor
6 associated with thin film density and volumetric wicking rate.
- 7 • Thin film density and volumetric wicking rate enhance CHF by accelerating bubble
8 departure frequency and delaying the dry-out at bubble base.
- 9 • CHF values from our experiments and literature data showed a positive linear correlation
10 with the unified descriptor.

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